



Generalized Magneto-Optical Ellipsometry (GME) for Magnetic Materials Characterization

- basic considerations
 - Light Polarization and Reflection
 - Jones Calculus and Ellipsometry
- Fundamentals of Magneto-Optics
 - dielectric tensor
 - Nomenclature of Magneto-Optical effects
 - size of the Magneto-Optical effect
- Generalized Magneto-Optical Ellipsometry
 - experimental set-up and capabilities
 - detection and analysis scheme
 - applications
 - recent developments

Andreas Berger



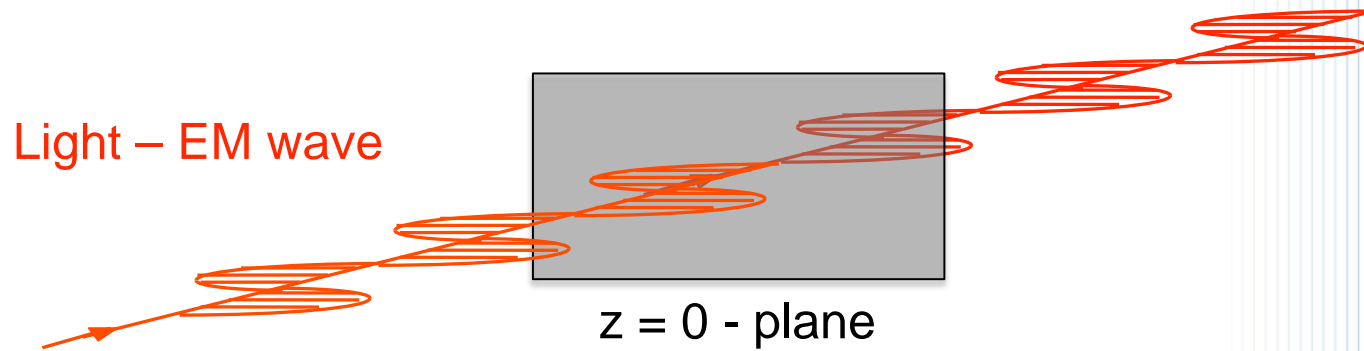
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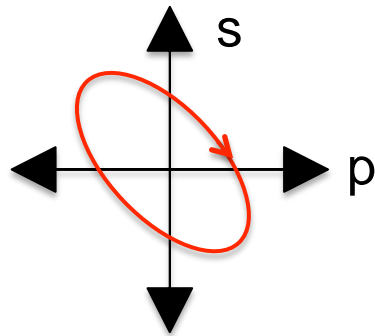
Light and Polarization

Polarized light



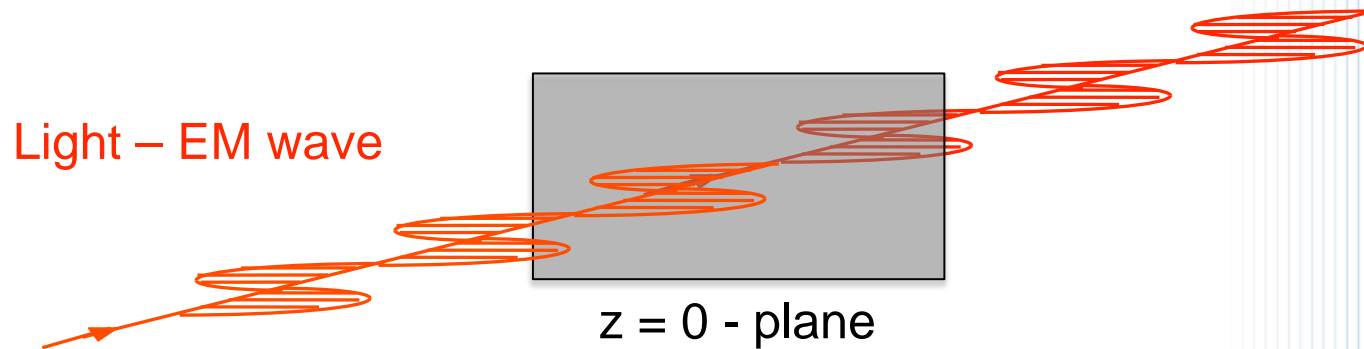
time evolution of the electromagnetic field in the $z = 0$ – plane

stable \rightarrow fully polarized: $P = 1$



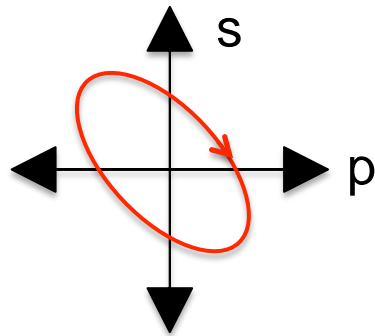
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Jones Calculus

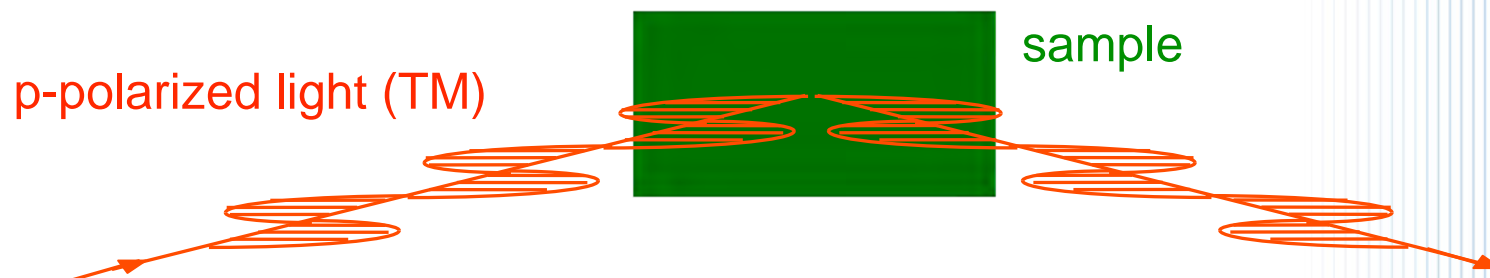
fixed \underline{k} , $P = 1$

$$\underline{E} = \begin{bmatrix} E_s \\ E_p \end{bmatrix} \exp(i(\underline{k} \cdot \underline{r} - \omega t))$$

$\underline{E} = 2 \times 1$ vector, E_s and E_p complex

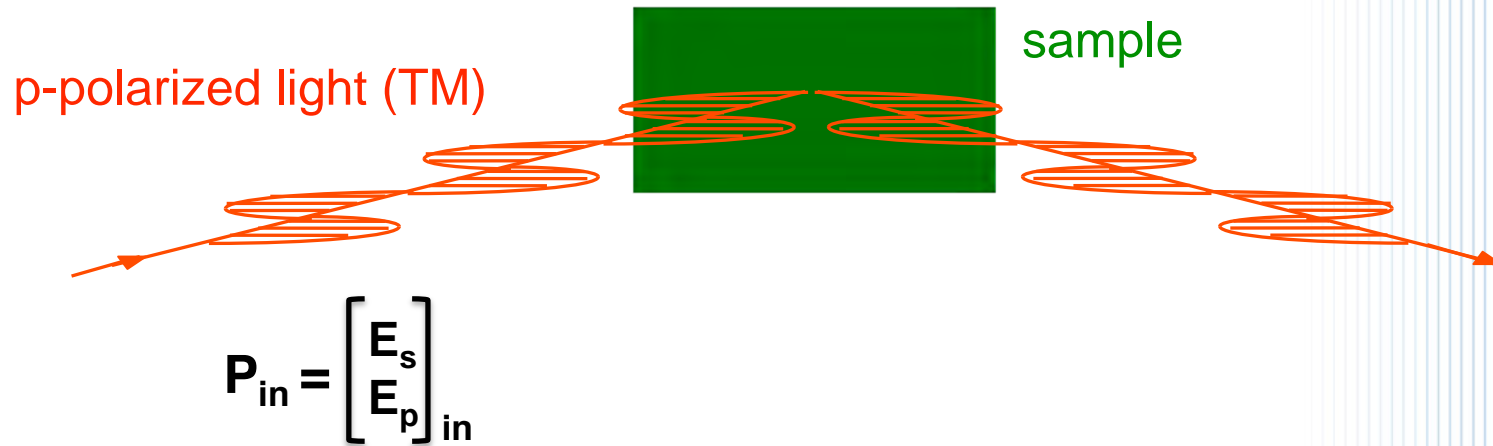
Light Reflection

Reflection from a flat surface



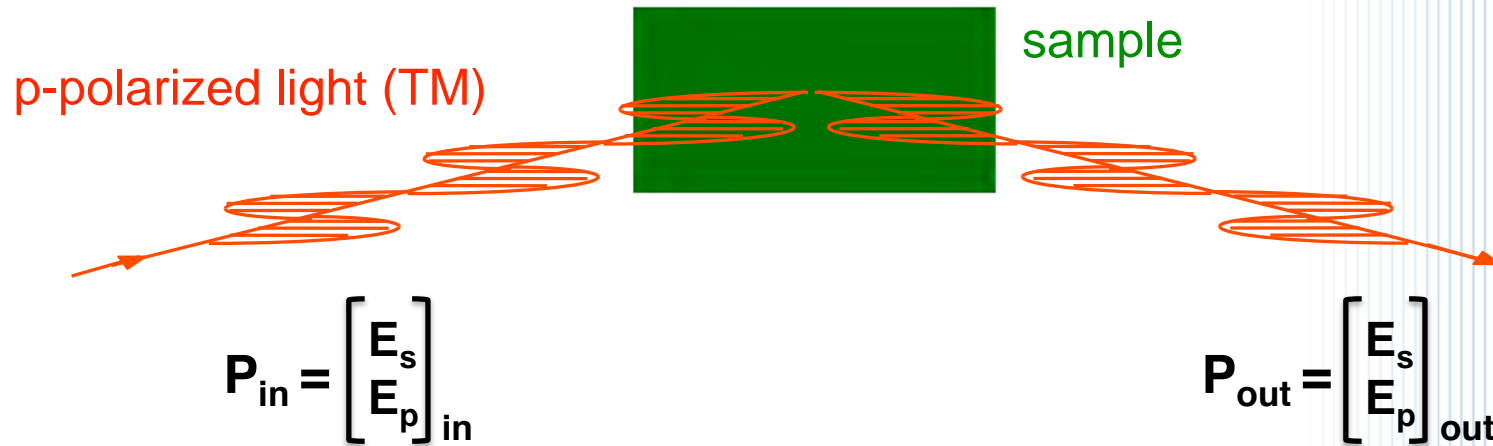
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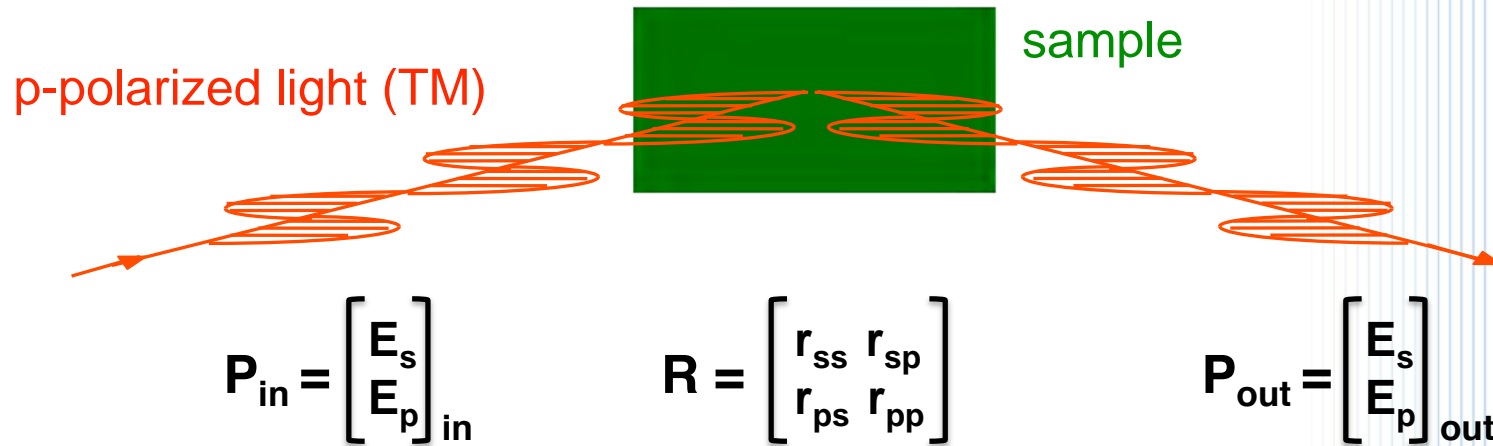
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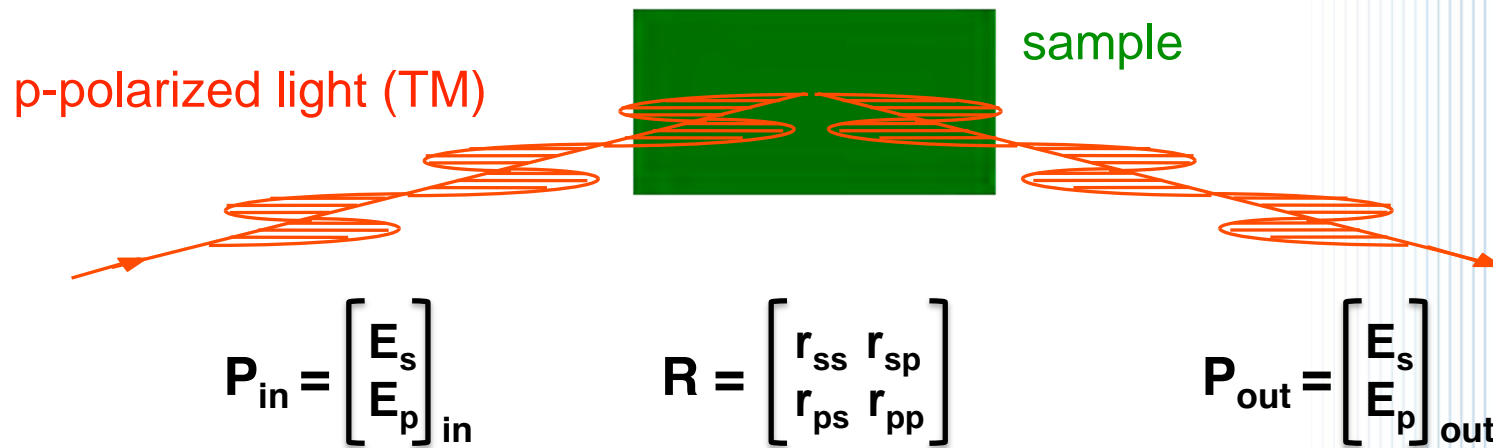
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Light Reflection

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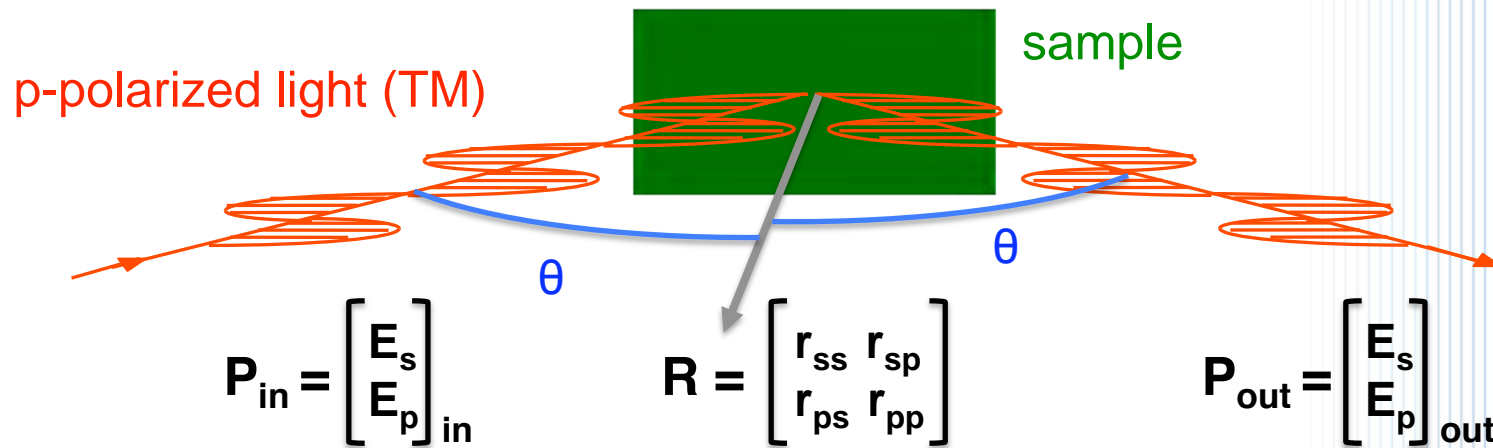


Plane-Wave Reflection from flat surface is fully described by a

2x2 reflection matrix **R** (applies to any optical element)

Light Reflection

Reflection from a flat surface



Plane-Wave Reflection from flat surface is fully described by a

R depends on geometry (θ) and material ϵ or $\epsilon(z)$

Ellipsometry: methodology to measure R to determine ϵ or $\epsilon(z)$



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Materials Optics: EM-wave propagation in the presence of matter

- Maxwell's equations: contain \underline{E} , \underline{D} , \underline{H} , \underline{B}
- linear materials relation: $\underline{D} = \underline{\epsilon} \underline{E}$; $\underline{B} = \underline{\mu} \underline{H} \rightarrow \underline{\epsilon}, \underline{\mu}$ are 3x3 tensors
- Optics: $\underline{\mu} = \mathbf{1}$
- Materials Optics (incl. Magneto-Optics): $\underline{\epsilon}$

- non-magnetic material: isotropic, cubic \rightarrow reflection matrix

$$\hat{\underline{\epsilon}} = \begin{bmatrix} \epsilon & 0 & 0 \\ 0 & \epsilon & 0 \\ 0 & 0 & \epsilon \end{bmatrix}$$

$$\begin{bmatrix} r_{ss} & 0 \\ 0 & r_{pp} \end{bmatrix}$$

Materials Optics: EM-wave propagation in the presence of matter

- magnetic material:
(1st order terms)

$$\hat{\varepsilon} = \varepsilon \begin{bmatrix} 1 & iQm_z & -iQm_y \\ -iQm_z & 1 & iQm_x \\ iQm_y & -iQm_x & 1 \end{bmatrix}$$

- Q is the magneto-optical coupling constant (λ)
- m_x, m_y, m_z are the components of **M**

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- m_x, m_y, m_z are the components of **M**
- Q is of the order of 10^{-4} - 10^{-3} for ferromagnets

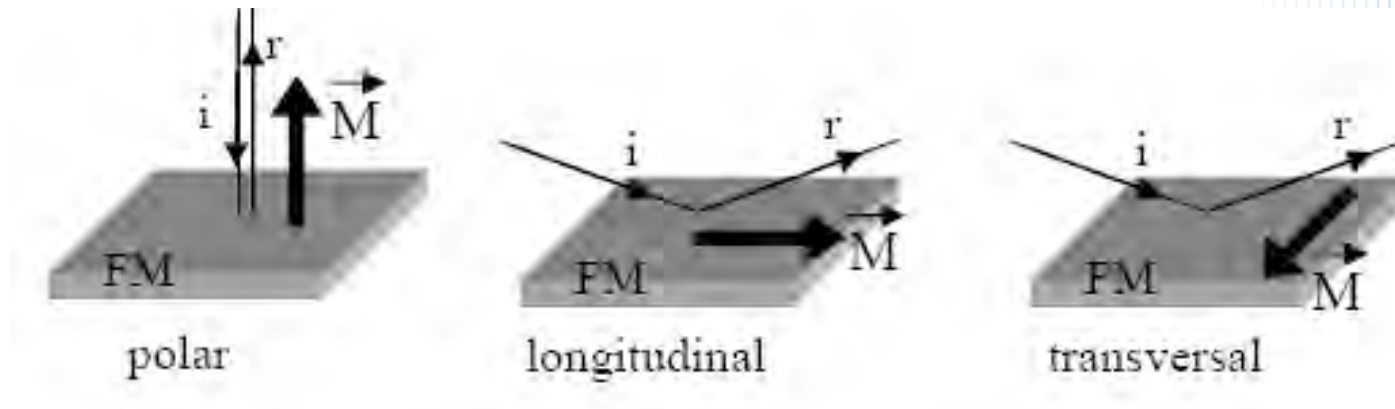
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- Optical Activity: M orientation dependence

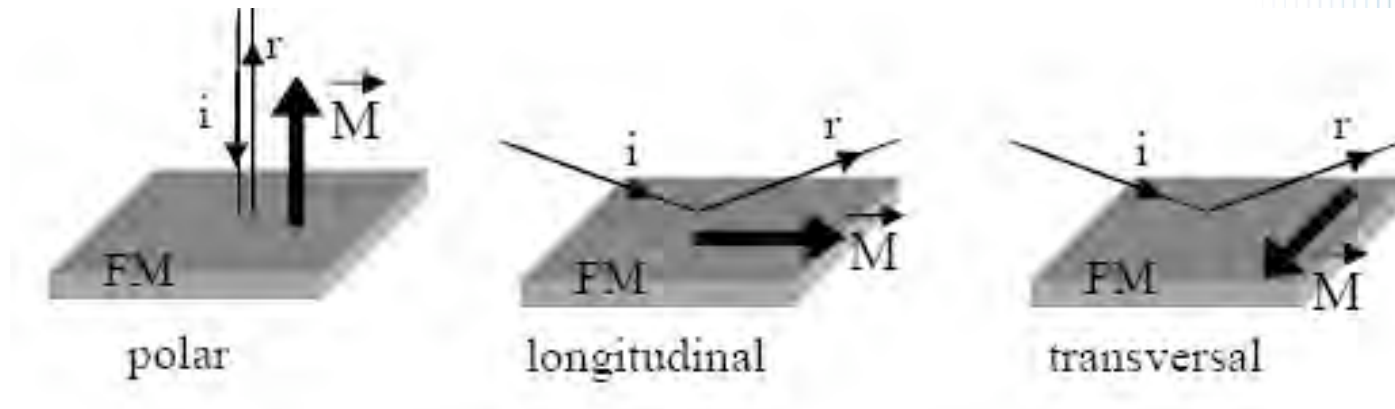
Nomenclature of Magneto-Optical effects



polar configuration

Dielectric Tensor	Reflectivity matrix
$ \begin{pmatrix} \epsilon_{xx} & \epsilon_{xy} \\ \epsilon_{yx} & \epsilon_{yy} \\ & & \epsilon_{zz} \end{pmatrix} $	$ R = \begin{pmatrix} r_{s \rightarrow s} & r_{p \rightarrow s} \\ r_{s \rightarrow p} & r_{p \rightarrow p} \end{pmatrix} $

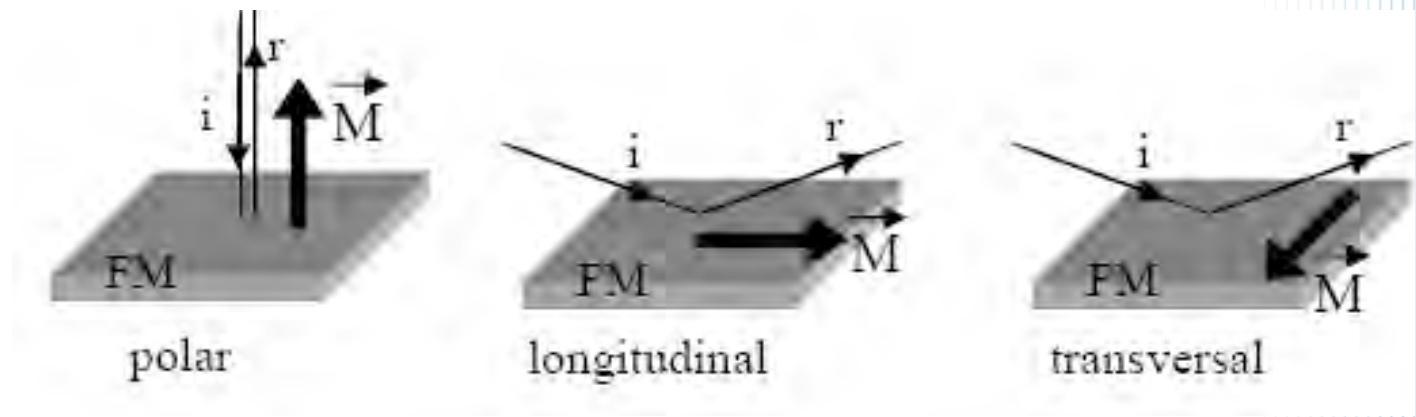
Nomenclature of Magneto-Optical effects



longitudinal configuration

Dielectric Tensor	Reflectivity matrix
$\begin{pmatrix} \epsilon_{xx} & & \\ & \epsilon_{yy} & \epsilon_{yz} \\ & \epsilon_{zy} & \epsilon_{zz} \end{pmatrix}$	$R = \begin{pmatrix} r_{s \rightarrow s} & r_{p \rightarrow s} \\ r_{s \rightarrow p} & r_{p \rightarrow p} \end{pmatrix}$

Nomenclature of Magneto-Optical effects



transverse configuration

Dielectric Tensor	Reflectivity matrix
$\begin{pmatrix} \epsilon_{xx} & \epsilon_{xz} \\ \epsilon_{zy} & \epsilon_{yy} \\ \epsilon_{zx} & \epsilon_{zz} \end{pmatrix}$	$R = \begin{pmatrix} r_{s \rightarrow s} & 0 \\ 0 & r_{p \rightarrow p} + \delta_p \end{pmatrix}$

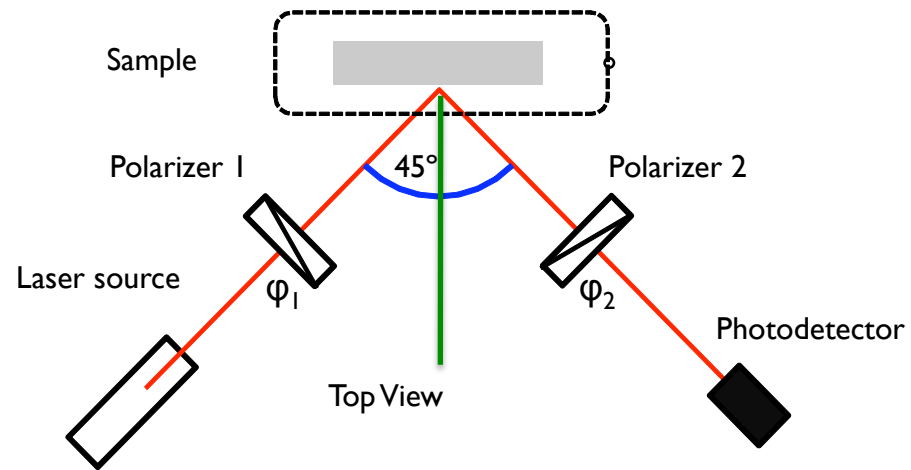


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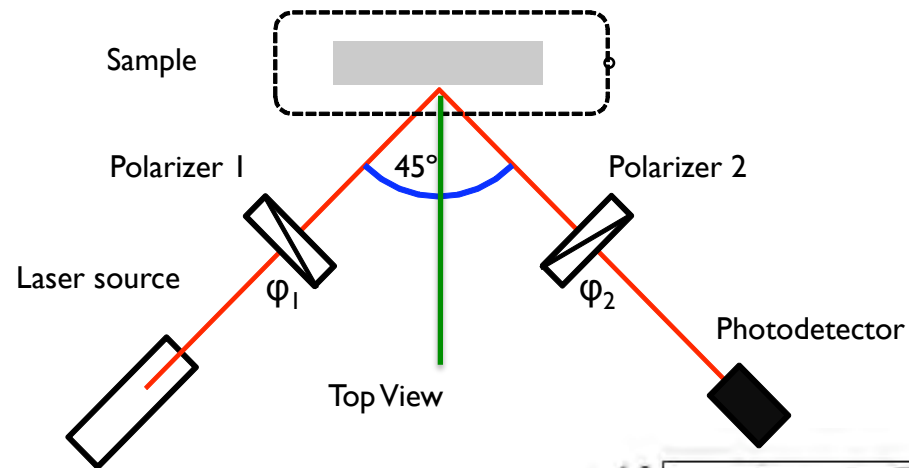
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crossed Polarizer set-up

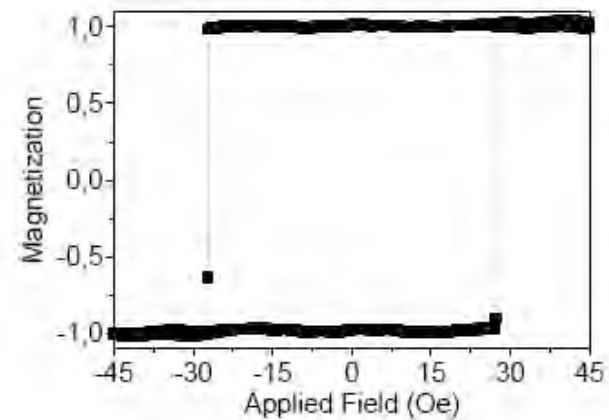


crossed Polarizer set-up



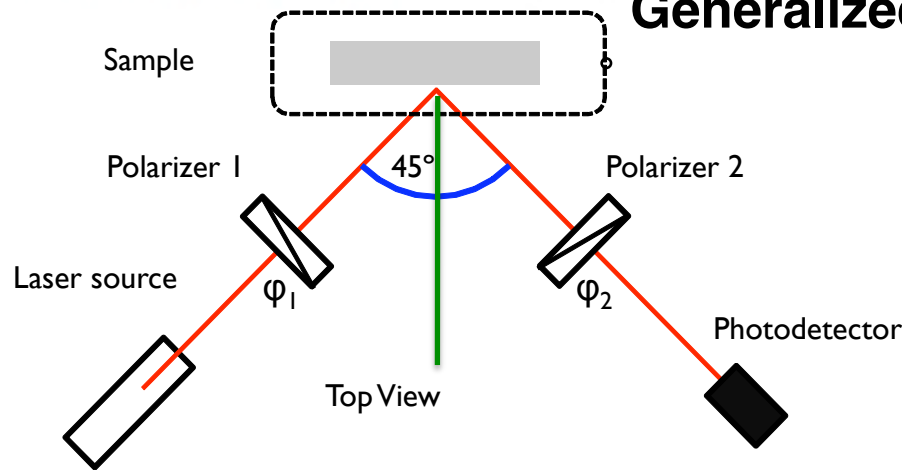
Performance: 30 nm Co-film

- complete hysteresis loop in 10 ms
- S/N-ratio = 48.2 (30 μ s)
- optical noise level 1 μ rad/ \sqrt Hz (DC)
(1/30 monolayer signal)



Experimental Magneto-Optics

Generalized Magneto-Optical Ellipsometry (GME)



**maximum information
from any
reflection experiment**

see A. Berger et al., APL **71**, 965 (1997)

Jones Matrices Analysis

$$E_D = r_p \begin{pmatrix} \cos^2 \varphi_2 & \sin \varphi_2 \cos \varphi_2 \\ \sin \varphi_2 \cos \varphi_2 & \sin^2 \varphi_2 \end{pmatrix} \begin{pmatrix} \tilde{r}_s & \tilde{r}_{ps} \\ -\tilde{r}_{ps} & 1 + \tilde{\delta}_p \end{pmatrix} \begin{pmatrix} \cos^2 \varphi_1 & \sin \varphi_1 \cos \varphi_1 \\ \sin \varphi_1 \cos \varphi_1 & \sin^2 \varphi_1 \end{pmatrix} \rightarrow I = |E_D|^2$$

$$\frac{dI}{I} = \frac{I^+ - I^-}{I^+ + I^-} = 4 \frac{B_1 f_1 + B_2 f_2 + B_3 f_3 + B_4 f_4}{f_3 + P_4 f_4 + P_5 f_5}$$

$$f_i = f(\varphi_1, \varphi_2)$$

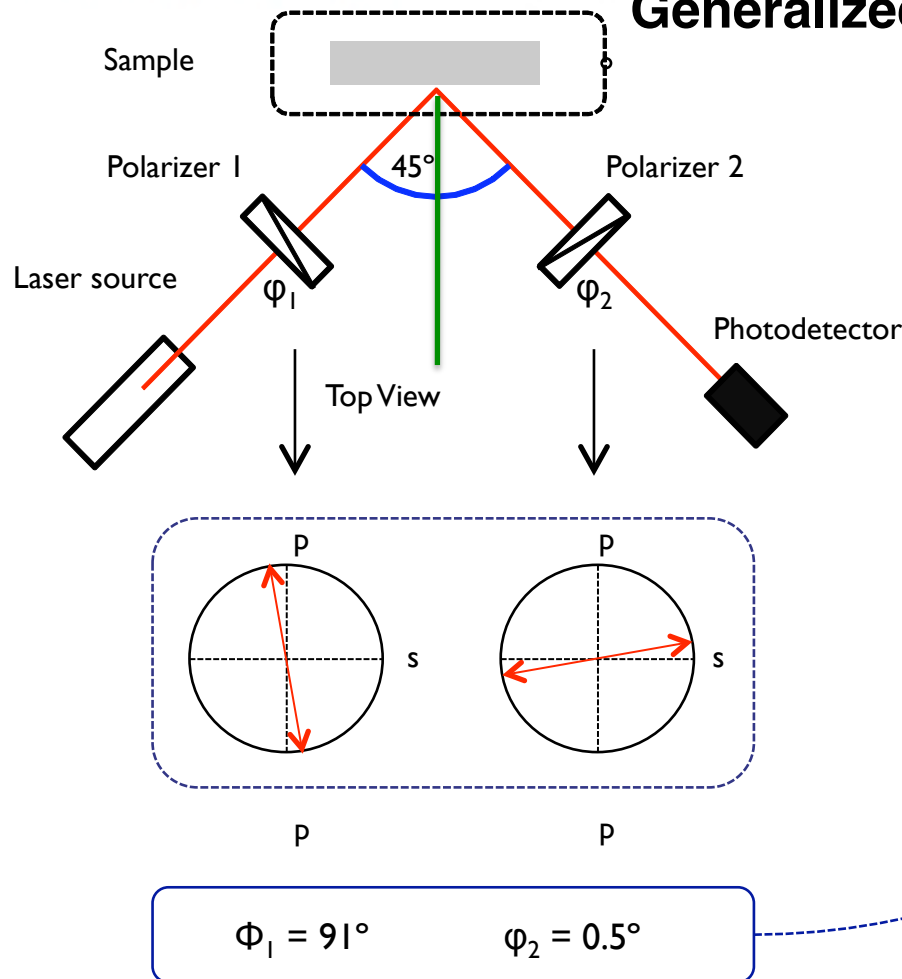
$$B_1 = \text{Re}(\tilde{r}_{ps}) \quad B_2 = \text{Re}(\tilde{r}_s \tilde{r}_{ps}^*) \quad \text{MO Longitudinal}$$

$$B_3 = \text{Re}(\tilde{\delta}_p) \quad B_4 = \text{Re}(\tilde{r}_s \tilde{\delta}_p^*) \quad \text{MO Transverse}$$

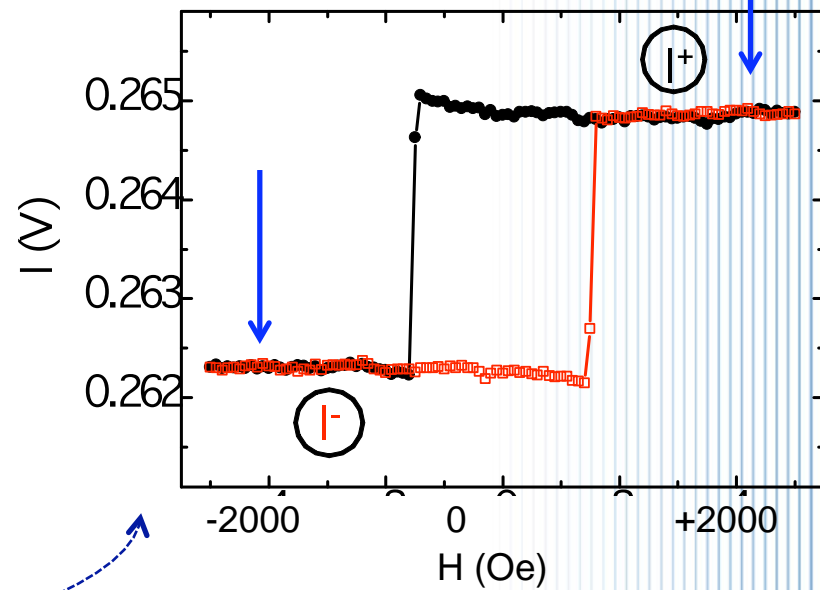
$$P_4 = 2 \text{Re}(\tilde{r}_s) \quad P_5 = |\tilde{r}_s|^2 \quad \text{Pure Optical}$$

Experimental Magneto-Optics

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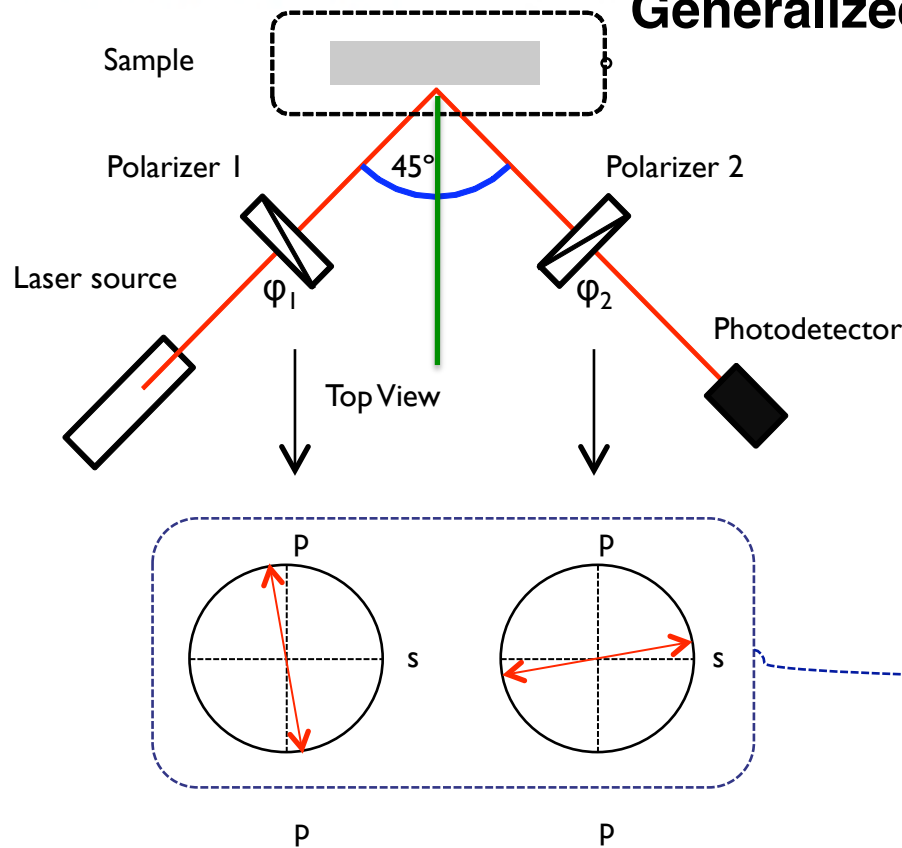


$$\frac{dI}{I} = \frac{I^+ - I^-}{I^+ + I^-}$$

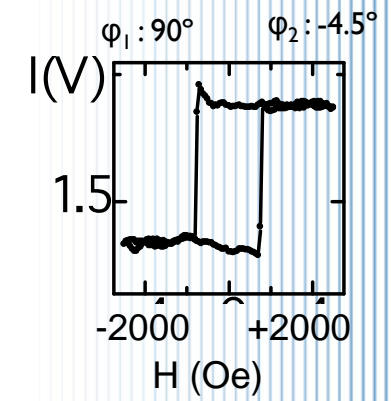
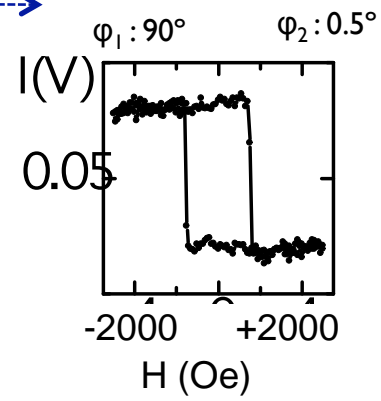
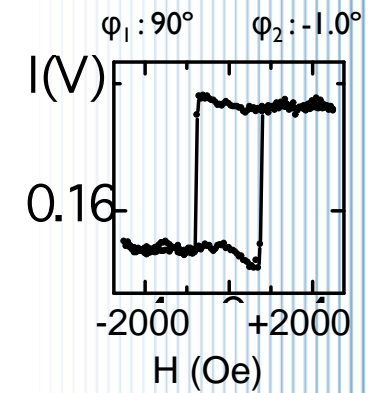
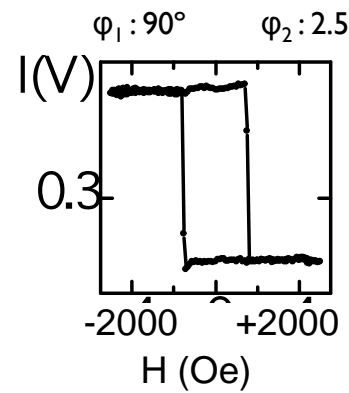


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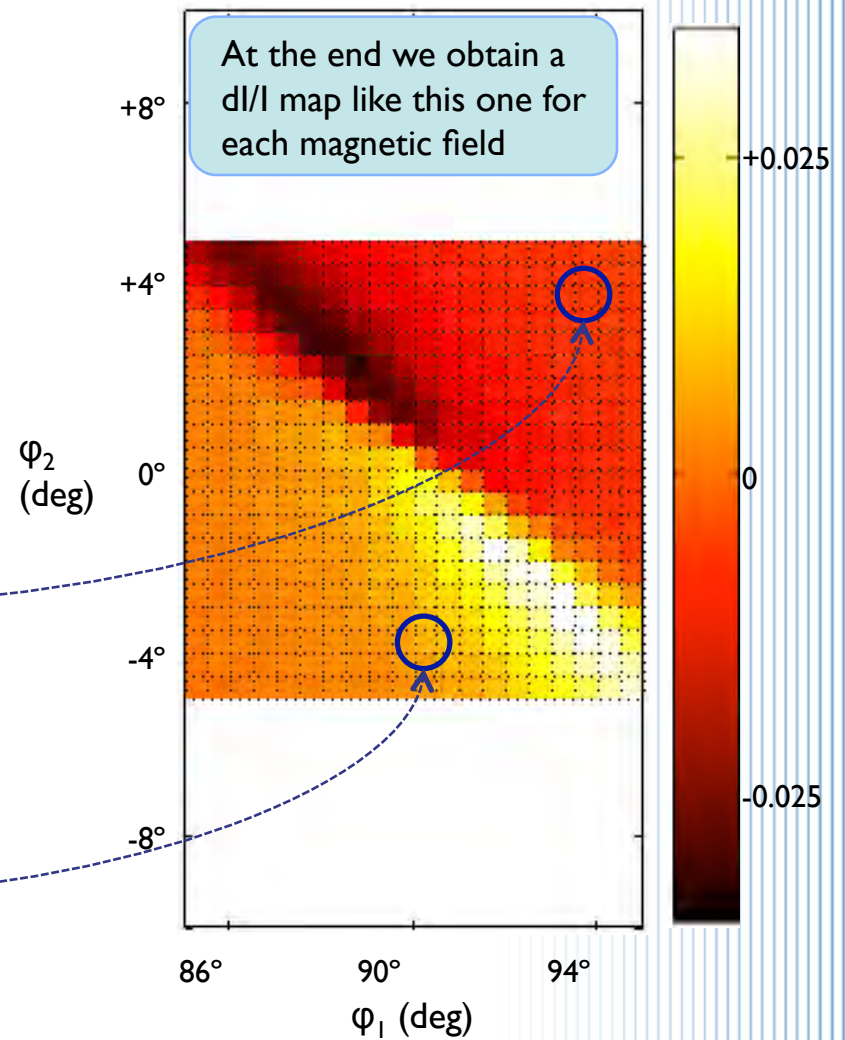
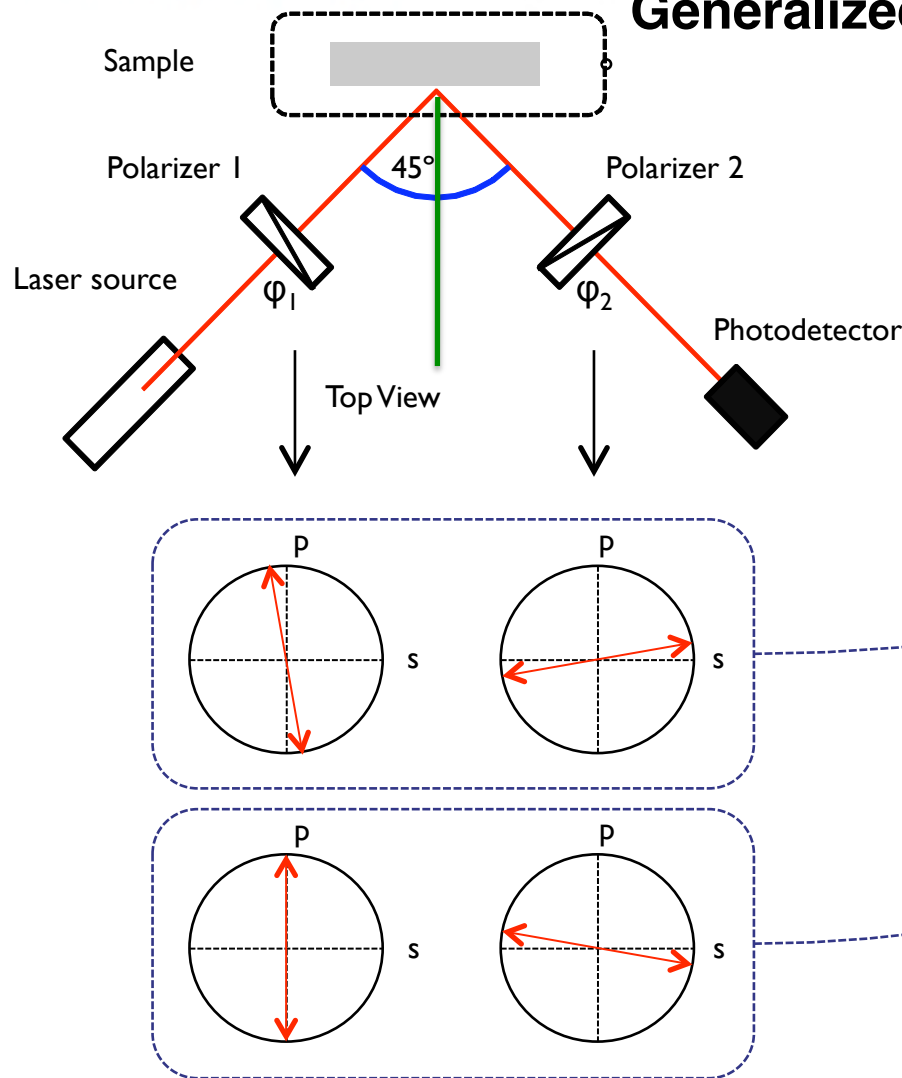


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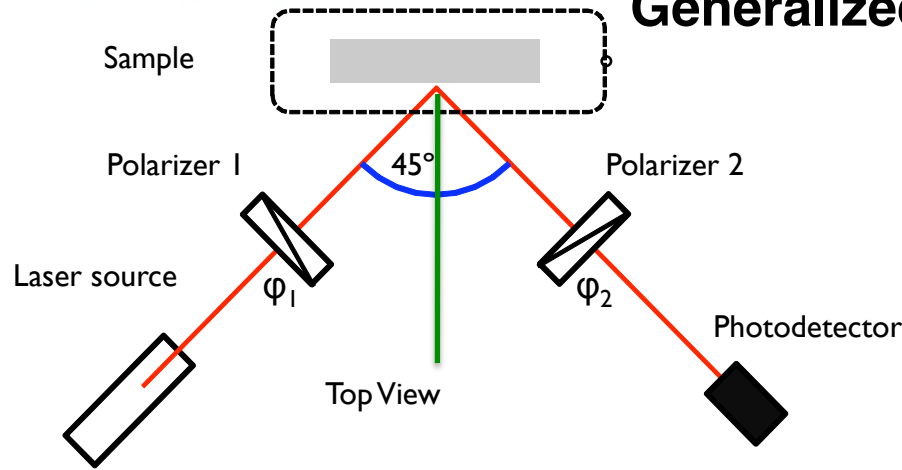
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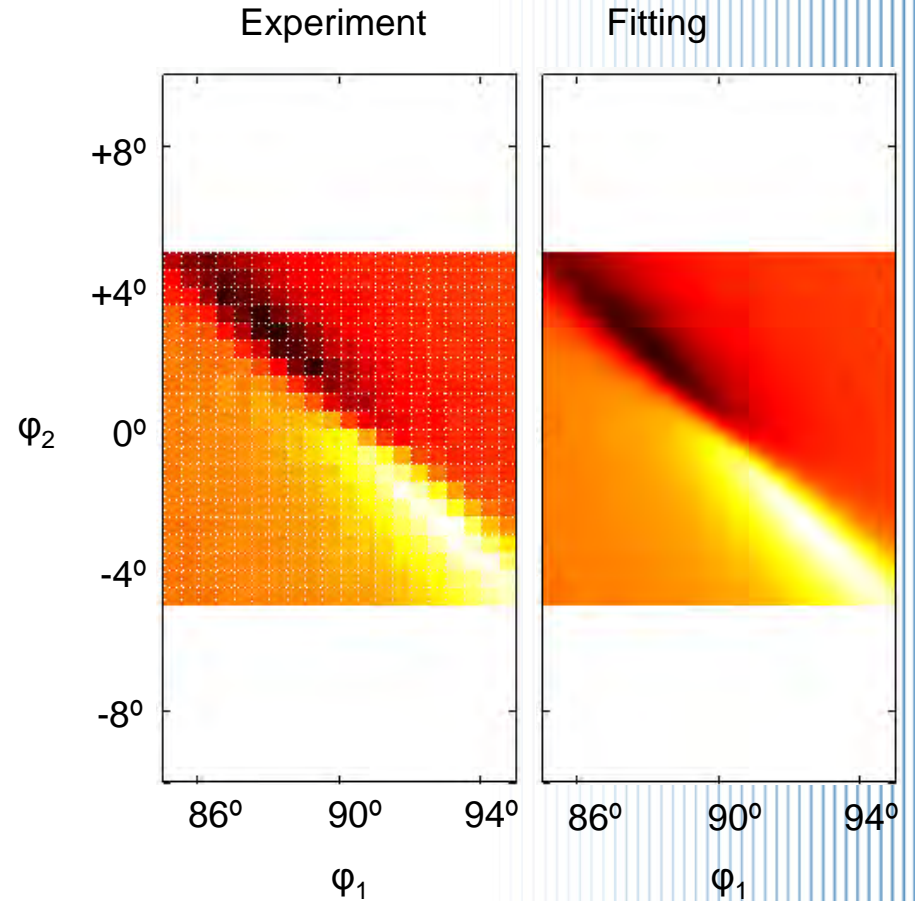
Non-linear Fitting

$$\frac{dI}{I} = 4 \frac{B_1 f_1 + B_2 f_2 + B_3 f_3 + B_4 f_4}{f_3 + P_4 f_4 + P_5 f_5}$$

Independent Variable: $\frac{dI}{I}$

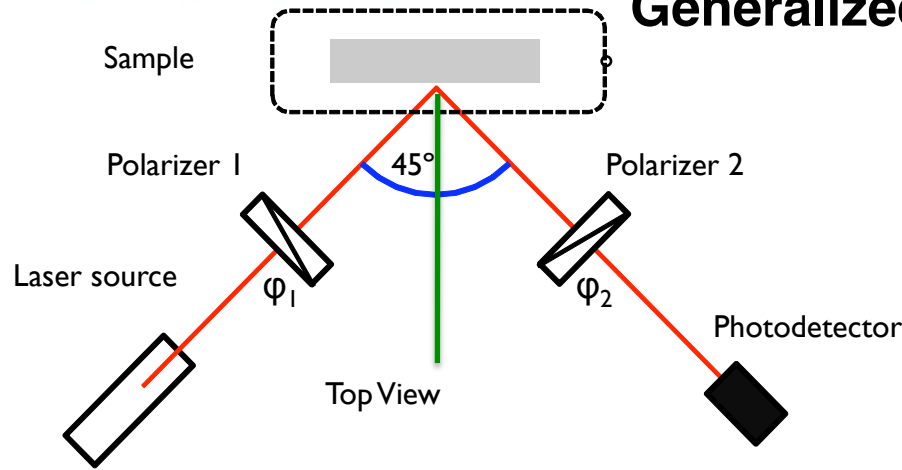
Dependent Variables: φ_1, φ_2

Fitting Parameters: $B_1, B_2, B_3, B_4, P_4, P_5$



Experimental Magneto-Optics

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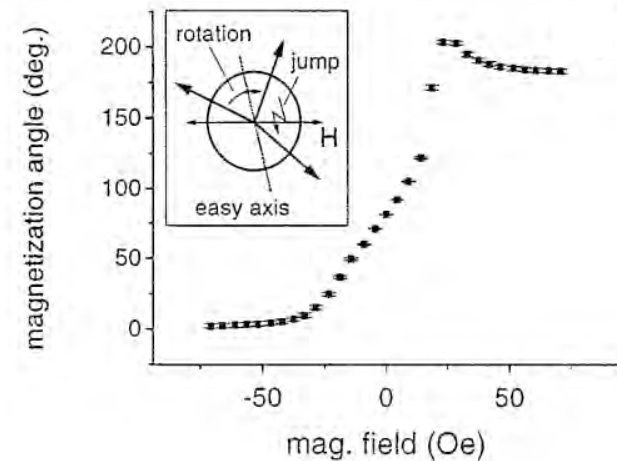
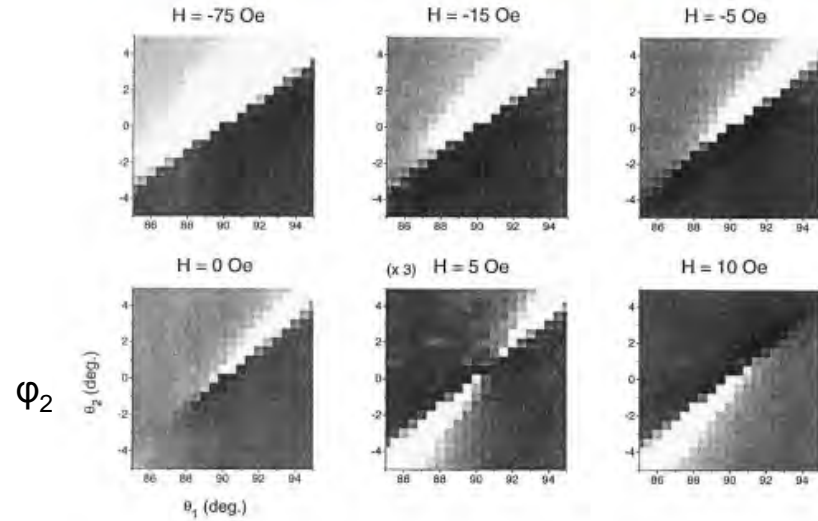
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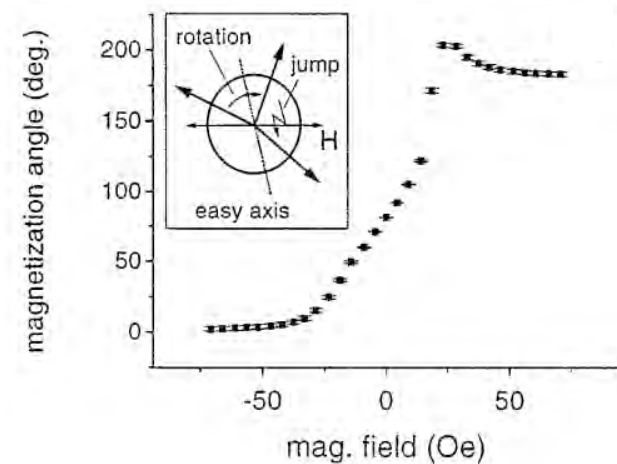
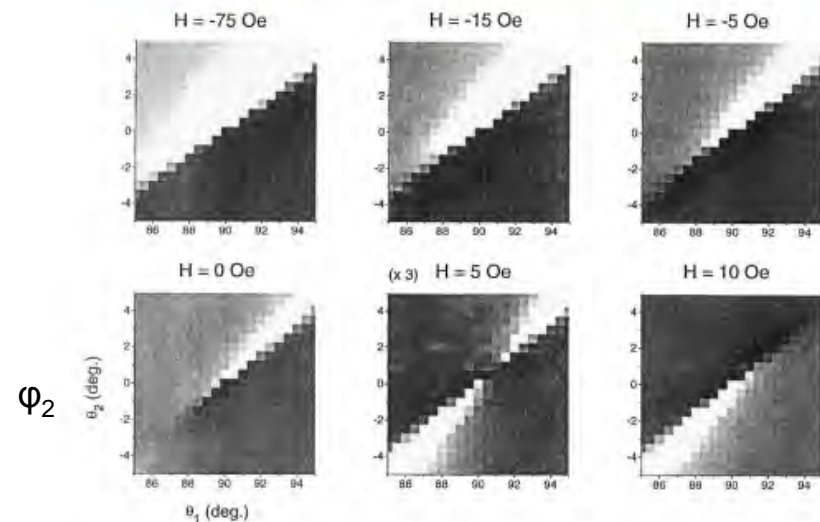
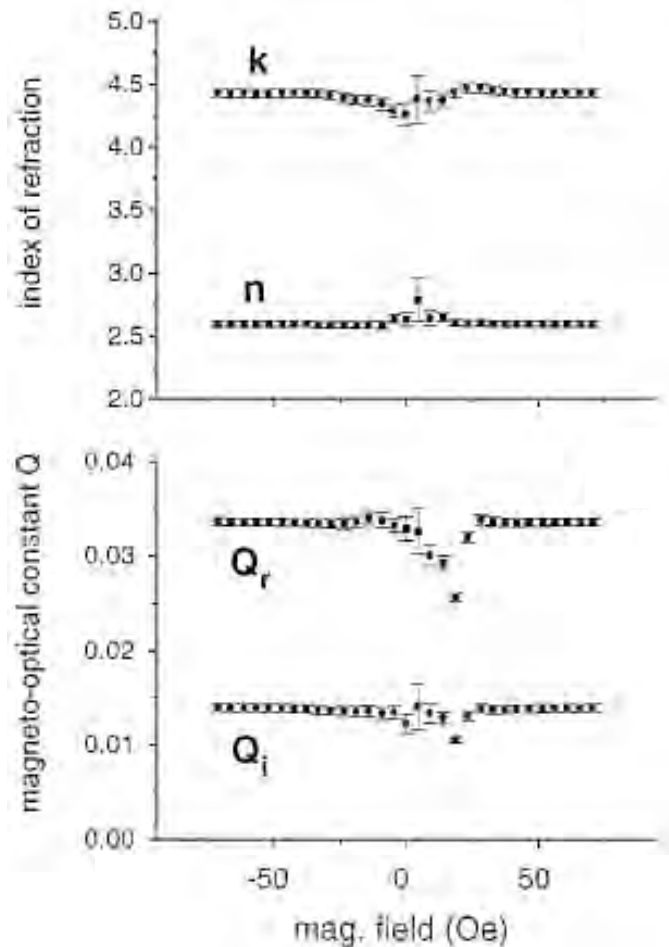
Full Vector magnetometry



Experimental Magneto-Optics

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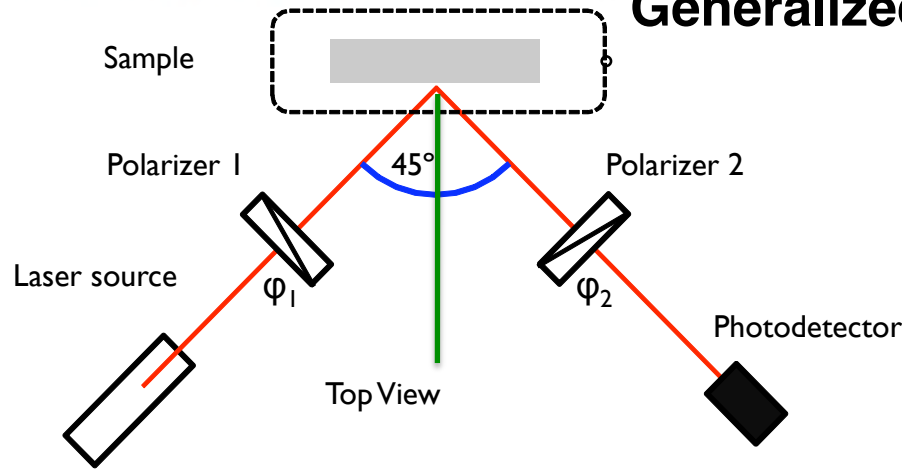
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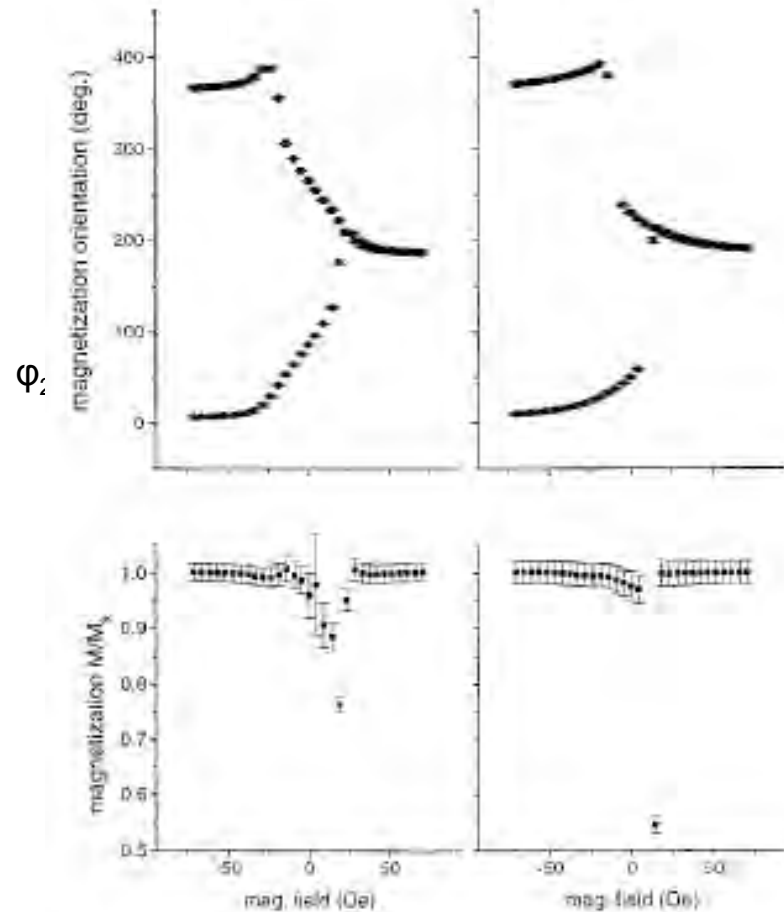
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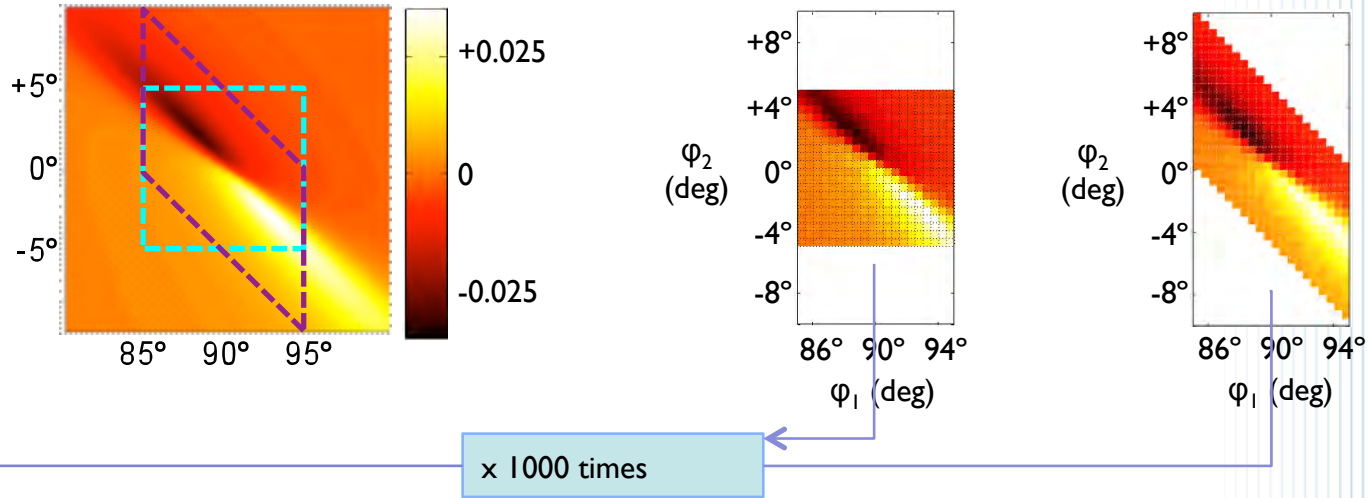
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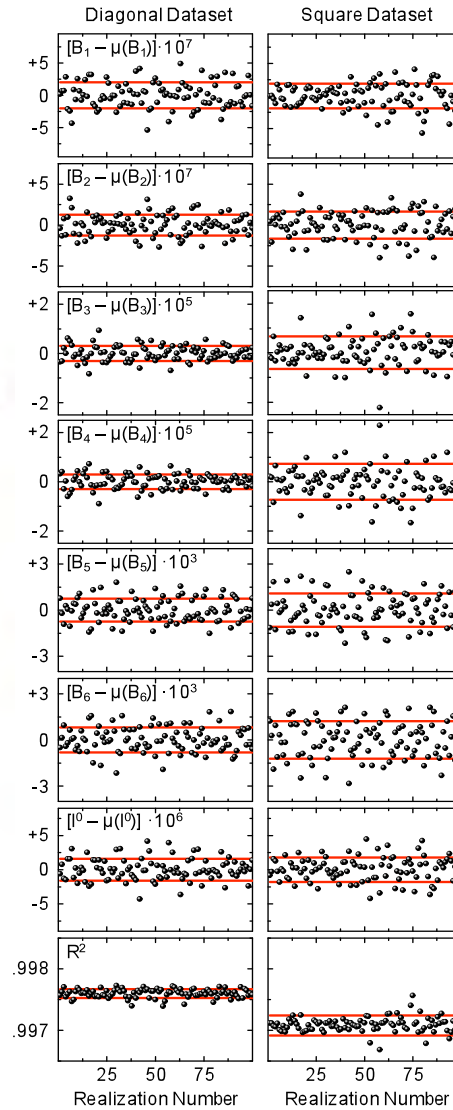
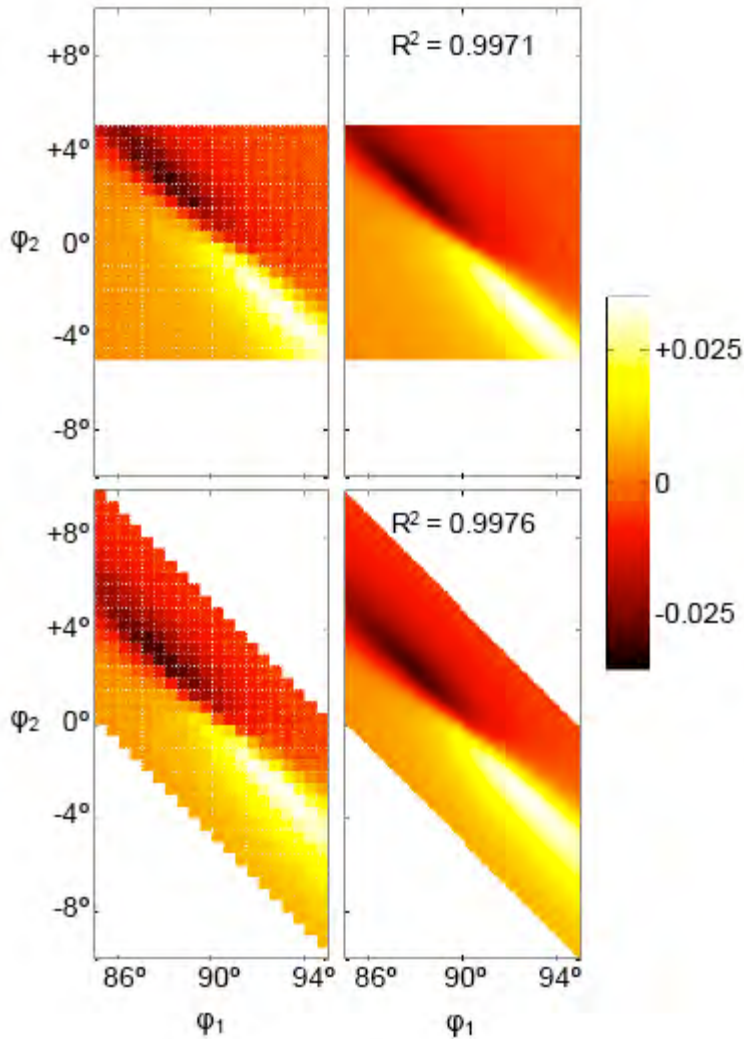


GME efficiency: data map

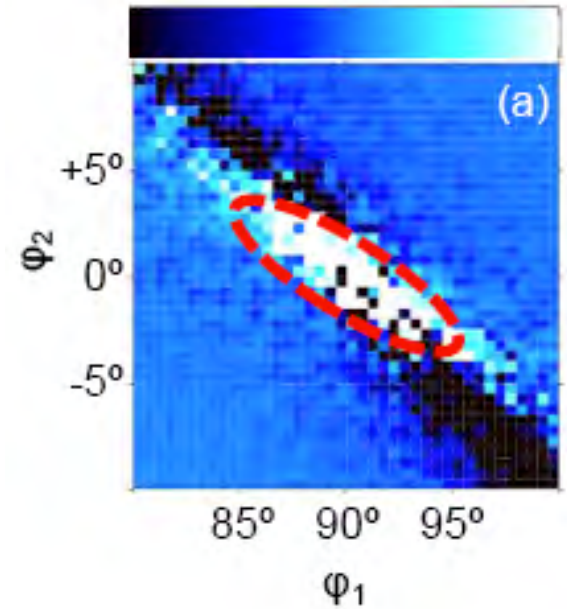


Parameter	Exact Value	Diagonal DataSet		Square DataSet	
		μ	σ	μ	σ
B_1	-1,39E-04	-1,390118E-04	9,684631E-07	-1,390971E-04	1,220211E-06
B_2	7,88E-05	7,879426E-05	8,083828E-07	7,886012E-05	9,363473E-07
B_3	1,65E-04	1,647655E-04	9,708091E-06	1,653061E-04	1,208305E-05
B_4	-5,00E-05	-4,959715E-05	1,432071E-05	-4,985288E-05	1,549608E-05
P_4	-1,824E+00	-1,823819E+00	6,823377E-03	-1,824084E+00	9,962343E-03
P_5	9,070E-01	9,067618E-01	6,976650E-03	9,066683E-01	9,052316E-03
I_0	2,00E-04	2,005070E-04	1,159999E-05	2,022689E-04	1,618046E-05

GME efficiency: data map



data point impact



Results:

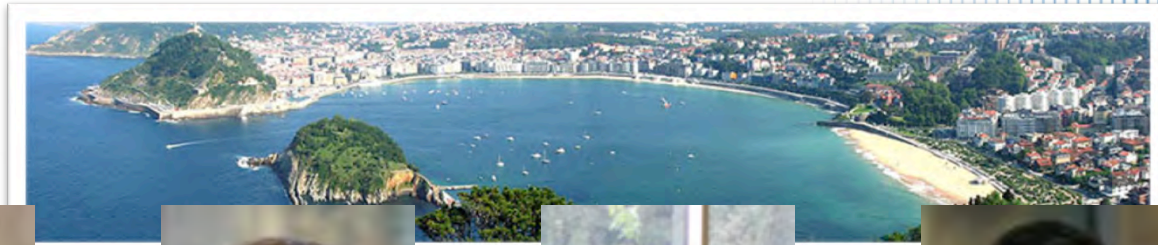
- SQ-lattice not optimal
- DIA-lattice clear better
- reliability improved
- efficiency improved



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Paolo Vavassori



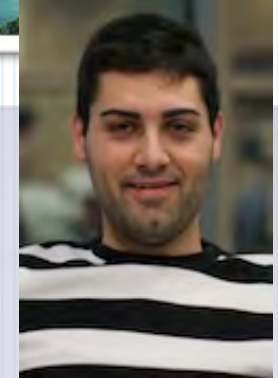
Jon Ander Arregi



Olatz Ididgoras



Juan Gonzalez



Cesar Rufo

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ETORTEK Program: Project IE06-172

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